

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/003,358	CHANG, FANG-CHENG
Examiner	Art Unit	
Sun J. Lin	2825	

SEARCHED

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB]	6/7/2005	JSL
IEEE	6/8/2005	JSL
IEEE	6/10/2005	JSL
GOOGLE	6/8/2005	JSL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
716	5	6/7/2005	JRL
716	19	6/7/2005	JBL